Negative Longitudinal Magnetoresistance in the Density Wave Phase of Y₂Ir₂O₇

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The ground state of nanowires of single-crystalline pyrochlore $Y_2Ir_2O_7$ is a density wave. The application of a *transverse* magnetic field increases the threshold electric field for the collective depinning of the density wave state at a low temperature, leading to colossal magnetoresistance for voltages around the depinning threshold. This is in striking contrast to the case where even a vanishingly small *longitudinal* magnetic field sharply reduces the depinning threshold voltage, resulting in *negative* magnetoresistance. Ruling out several other possibilities, we argue that this phenomenon is likely to be a consequence of the chiral anomaly in the gapped out Weyl semimetal phase in $Y_2Ir_2O_7$.

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With comparable energy scales of the spin-orbit coupling, the effective bandwidth, and the Coulomb correlation, pyrochlore iridates $R_2 Ir_2 O_7$ (R = yttrium or lanthanide elements) have emerged as a very promising quantum many-body system. This has opened up the possibility of the realization of a variety of novel quantum phases [1-6] including Weyl semimetals [3,7,8] in pyrochlore iridates. However, to date, experimental evidence of a Weyl semimetal (WSM) in iridates has remained elusive, except for a suggestion of a metal-semimetal transition in the optical conductivity study of Eu₂Ir₂O₇ [9]. Apart from the practical problem of fabricating clean single crystals of iridates, other fundamental reason could be that Weyl nodes gap out due to the predicted density wave instabilities either caused by Coulomb correlation or induced by a magnetic field [6.10–14].

In a recent work, we demonstrated the existence of charge density wave (CDW) order in single-crystalline nanowires of pyrochlore iridates [15]: $Y_{2-x}Bi_xIr_2O_7$ with x = 0 (YIO) and 0.3 (YBIO). However, the physical origin of the observed CDW instability in YIO and YBIO is not clear. It can arise from the natural propensity towards Peierls instability in low-dimensional systems. More interestingly, it can also be a consequence of spontaneously broken chiral symmetry in three-dimensional WSM—in which case it may carry the signature of axion dynamics [11,16]. To address this issue, investigating the properties of the density wave state in the presence of an external electromagnetic field would be an effective way of either establishing or ruling out the WSM phase in $Y_2Ir_2O_7$.

In this Letter, we show the existence of a CDW ground state in single-crystalline YIO nanowires and study the transverse ($\mathbf{H} \perp \mathbf{E}$) and longitudinal ($\mathbf{H} \parallel \mathbf{E}$) magnetoresistance in the sliding state of the density wave. We show that the threshold electric field for the collective depinning of the density wave increases on the application of a transverse magnetic field, and since the nonlinear conductivity,

contributed by a sliding CDW, is much higher than that of the normal quasiparticles, this leads to a *colossal* magnetoresistance (MR). On the other hand, the application of even a tiny longitudinal magnetic field component leads to a significant reduction of the depinning threshold, resulting in *negative* MR. Among the possible factors leading to the observed negative MR, we rule out weak localization, current jetting, and the reconstruction of the Fermi surface in the presence of a magnetic field. We suggest that this seemingly nonperturbative effect of a tiny magnetic field (**H**||**E**) on the depinning threshold and the observed negative MR may be a consequence of the chiral anomaly or the coupling of the phase fluctuations of the axionic CDW to the **E** · **H** term [11].

Single-crystalline nanowires of YIO were prepared following the method of Refs. [15,17] and drop cast on a silicon oxide substrate with subsequent metallization using e-beam lithography-see Fig. 1(f). For details of device fabrication and chemical characterization, see [18]. HRTEM and selected area electron diffraction (SAED) are sensitive to the periodic lattice distortions accompanying CDW. The SAED pattern in the (110) zone axis confirms that the lattice symmetry of the bulk is preserved in the nanowire [see Fig. 1(d) and Ref. [18] for details]. The real space HRTEM image in Fig. 1(a) is characterized by a bright-dark contrast modulation due to the periodic lattice distortion. We also observe one-dimensional satellite spots confirming the presence of a new lattice periodicity which could be attributed to the CDW instability [Fig. 1(e)]. A distinct and unique off-axis CDW structure can be seen in the SAED. The off-axis CDW shows a lattice modulation characterized by the wave vector \mathbf{q}_1 defined as $\mathbf{q}_1 = 0.23 \mathbf{a}^* + 0.27 \mathbf{b}^*$, where $|\mathbf{a}^*| = 5.61/\text{nm}$ and $|\mathbf{b}^*| = 5.61/\text{nm}$ 3.96/nm [see Fig. 1(e)]. The superlattice spots in other wave vector directions are not observed, thus negating any possibility of the occurrence of "chiral CDW" [19] arising out of interference between coexisting density waves with



FIG. 1. (a) Real space HRTEM image of a portion of a 150 nm (diameter) YIO nanowire showing lattice fringes. Inset: TEM image of the same. (b) The magnified HRTEM image shows the periodic lattice distortion along the long axis "a" of the nanowire. (c) A 3D projection of the real space image in (b) gives direct evidence of the periodic lattice distortion along the *a* axis. (d) SAED pattern of the YIO nanowire in the (110) zone axis with distinct Bragg spots. (e) The area highlighted in (d) is enlarged to show satellite spots (circled for improved visibility) due to density wave formation. (f) Panel I: dc IV characteristics of a switching or hysteretic (red curve) and a nonswitching or nonhysteretic (blue curve) YIO device at 1.3 K. Inset: SEM image of a representative device for transport measurement. Panel II: Dielectric spectroscopy of YIO: frequency dependence of the real and imaginary parts of the dielectric permittivity, at different temperatures from 80 to 290 K scaled on a universal relaxation curve-Eq. (1)-represented by the solid red line. The temperature dependence of ω_p (prominent relaxation frequency in the ac response) is given in Supplemental Material [18].

separate wave vectors. The real space 2D HRTEM image at higher magnification and its 3D projection in Figs. 1(b) and 1(c) provide a direct visualization of the periodic lattice distortion.

Based on the low-temperature IV characteristics (measured using the pulsed IV method to eliminate selfheating effects) of a number of YIO nanowire devices, we categorize them into switching and nonswitching ones. For switching crystals, we find Ohmic behavior up to a certain threshold voltage value V_T , and beyond V_T there is a sharp hysteretic jump into a highly conducting nonlinear state. At a higher temperature, the hysteresis and switching behavior disappears, though there is still significant nonlinear transport. For nonswitching crystals, we find highly nonlinear but smooth behavior beyond the Ohmic regime even at a low temperature [Fig. 1(f)]. The origin of nonlinear transport including hysteretic switching in CDW has been discussed earlier [20-24]. The nonlinear conduction, the switching behavior, and the associated threshold V_T can be dramatically tuned by changing the cooling rate [15]. On rare occasions, we observe colossal enhancement of conductivity over the entire temperature range, when the sample is cooled sufficiently rapidly (see Fig. 2 of Ref. [18]). Since the impurity concentration is unlikely to change with a change in the cooling rate, this phenomenon could be related to the formation of dislocations in the CDW which possibly act as axion strings [11]. The chiral modes along the axion strings can carry dissipationless current leading to high conduction channels.

The low-frequency dielectric response was measured at different temperatures, using the standard lock-in technique. In Fig. 1(f), we show the real and imaginary parts of the low-frequency dielectric response [related to the ac conductivity via the relation $i\omega\epsilon(\omega) = \sigma(\omega) - \sigma_0$, where σ_0 denotes the dc conductivity] for several temperatures (from 80 to 290 K). A similar dielectric response for YBIO nanowire was reported earlier [15]. The dielectric response at different temperatures [see Fig. 1(f)] follows the generalized Debye relaxation formula [25], which includes a skewed distribution of the dielectric relaxation rates and is given by

$$\frac{\epsilon(\omega) - \epsilon_{\infty}}{\epsilon_0 - \epsilon_{\infty}} = \frac{1}{\{1 + [i\omega\tau(T)]^{1-\alpha}\}^{\beta}}.$$
 (1)

Here α denotes the temperature-dependent width and β the skewness of the distribution of dielectric relaxation rates.

The transport characteristics of a single-crystalline YIO nanowire device change significantly in the presence of a magnetic field. The dc electrical transport characteristics for nonswitching as well as switching devices in the presence of a transverse magnetic field $(\mathbf{H} \perp \mathbf{E})$ is shown in Figs. 2(a) and 2(c), respectively. We find that the threshold electric field V_T increases with an increasing transverse magnetic field and saturates beyond a field strength of 1 T [see Fig. 2(b)]. Figure 2(d) shows the transverse MR[=R(H)/R(0) - 1 = I(0)/I(H) - 1] as a function of the applied voltage and magnetic fields. Since there is linear (Ohmic) conduction below V_T and nonlinear (CDW) conduction above it, the magnetic-field-induced shift in V_T results in a huge enhancement of magnetoresistance (colossal MR up to $\sim 2 \times 10^3$) around the zero field depinning threshold—as highlighted in Figs. 2(d) and 2(e). The colossal MR is a consequence of the huge difference in the current carried by the normal carriers before the CDW starts sliding and the large nonlinear current carried by the sliding CDW.

While the threshold voltage first increases and then saturates with increasing H [Fig. 2(b)], with an increasing temperature, $\Delta V_T = V_T(H) - V_T(0)$ decreases (almost linearly) as shown in the inset in Fig. 2(c). The increase of the threshold electric field in the presence of a transverse magnetic field in density waves has been addressed theoretically by Maki *et al.* [26]. In the weak pinning limit, a magnetic field perpendicular to the conducting plane of a DW reduces the elastic constant associated with the transverse phase distortion of the DW, leading to an increase in the threshold electric field. A similar argument for the increase of V_T with the application of a transverse magnetic field has also been shown to work in the strong pinning limit so long as there is imperfect nesting [26].



FIG. 2. (a) dc IV characteristics of a YIO nanowire (nonswitching device) in the presence of a transverse magnetic field at 1.3 K. (b) The magnetic field dependence of the threshold voltage V_T . (c) The IV characteristics in the presence of a transverse magnetic field at higher temperatures for a switching device. At 40 K, the switching identified with discontinuity in the I-Vcharacteristics for H = 0 gets more pronounced in the presence of a transverse magnetic field. Inset: The temperature dependence of the change in V_T on the application of a 0.6 T magnetic field. (d) The 2D color plot of transverse MR in the H-V plane for the same sample, which shows colossal MR around the depinning voltage (~ 18 V). (e) The corresponding bias dependence of MR at different magnetic fields. The inset shows the H dependence of MR for different bias voltages. (f) The broad qualitative features of the 2D color plot of the transverse MR in the H-V plane are captured reasonably by a simple model including only the Hdependence of the threshold voltage V_T .

The dc transport characteristics for a low magnetic field change dramatically when a component of the magnetic field is applied along the current direction (in this case, the angle between **H** and **E** being 40°). The *I*-V curve for a nonswitching YIO device is shown in Fig. 3(a). Focusing on the threshold voltage behavior, even a small component of a parallel magnetic field reduces $V_T(H)$ drastically, in both strong pinning (switching samples—see Fig. 4 in Ref. [18]) and weak pinning (nonswitching samples) regimes as shown in Fig. 3(b). On increasing the magnetic field further, V_T fluctuates a little with its mean value not changing significantly. This seemingly nonperturbative behavior of a sudden decrease of V_T even for a tiny magnetic field component along the transport direction has not been reported earlier (to the best of our knowledge) in any CDW system. While a



FIG. 3. (a) dc *IV* characteristics in the presence of magnetic fields applied at 40° to the electric field direction in a nonswitching device. (b) V_T abruptly shifts to a lower value (from 23 to 17 V) on the application of even a small magnetic field. (c) MR versus *V* for different *H* values. For $V \approx 18$ V we see the transition from almost negligible MR to significant negative MR, and for V > 18 V all curves have MR < 0. The negative MR for $V_T(H) < V < V_T(0)$ at all magnetic field values is a consequence of the drastic reduction of V_T in the presence of a longitudinal component of the magnetic field. (d) A 2D color plot of the experimentally observed MR in the *H*-*V* plane. (e) MR vs *H* at constant bias currents showing negative MR at a low magnetic field. (f) The broad qualitative features of the longitudinal MR in the *H*-*V* plane is reasonably reproduced by the model discussed in the text.

detailed theoretical understanding of this is lacking, there is a possibility of it being related to the chiral anomaly in Weyl semimetals, which leads to a charge imbalance (proportional to $\mathbf{E} \cdot \mathbf{H}$) between the two opposite chirality nodes. This seems plausible, since, even for a small parallel component of \mathbf{H} , the large value of the threshold voltage implies that $\mathbf{E} \cdot \mathbf{H}$ is not insignificant.

The sudden reduction of V_T even for a tiny longitudinal **H** component, combined with the much higher CDW nonlinear conductivity as compared to the normal quasiparticles Ohmic conductivity, leads to a negative MR in the bias range $V_T(H) < V < V_T(0)$. The very high value of the CDW nonlinear conductivity also limits the negative low field longitudinal MR[=I(0)/I(H) - 1] to a minimum value of -1.

For bias fields above the zero magnetic field threshold, $V > V_T(0)$, we observe positive MR similar to the case when the magnetic field is applied in the transverse direction. This simply indicates that the nonlinear sliding CDW conductance decreases with an increasing magnetic field. For devices which remain Ohmic in a zero magnetic field, we observe negative MR all throughout [see Fig. 3(d) of Ref. [18] for an example].

When the magnetoresistance is measured at a constant bias current (instead of constant voltage), we observe negative MR at a low magnetic field for low bias currents followed by positive MR at higher bias currents [see Fig. 3(e)]. This is consistent with the constant voltage measurements and can be understood qualitatively from Fig. 3(a): In a constant current measurement, increasing H leads to decreasing V for the isocurrent condition. Thus, the constant current MR[=V(H)/V(0) - 1.0] also has to be negative as long as the depinning current threshold $I_T(H) < I_T(0)$. The magnitude of the MR is, however, much less compared to that obtained for constant voltages. Usually, in nonswitching samples there should be very little difference between constant voltage and constant current measurements. However, for switching samples or samples with strong nonlinearity near the depinning threshold, the two measurements can differ widely [27].

To highlight the importance of the variation of $V_T(H)$ in the observed MR behavior, we construct a simple phenomenological model. In the DW pinned regime, $V < V_T(H)$, the quasiparticle current is Ohmic and does not depend on the magnetic field; thus, $I_{qp}(H, V) = V/R$, where R is the resistance and V is the applied voltage across the nanowire device. In the sliding CDW regime, $V > V_T(H)$, the current can be modeled via $I(H, V) = I_{qp}(H, V) + I_{cdw}(H, V)$, where I_{cdw} is the nonlinear CDW current. We use a simple expression for the voltage dependence of CDW conductance based on Bardeen's tunneling theory [28]: $I_{dw}(V) = I_0(V - V_T)e^{-V_0/V}$, where I_0 and V_0 are constants. By incorporating the observed $V_T(H)$ in the model described above and making the very simple assumption of I_0 and V_0 being H independent, the broad qualitative features of the MR observed for both the transverse as well as the longitudinal case could be reproduced, as shown in Figs. 2(f) and 3(f), respectively.

There are several plausible reasons for the observed negative longitudinal magnetoresistance for $\mathbf{E} || \mathbf{H}$ in our experiment. (i) YIO has been predicted to host Weyl fermions [3], and in the presence of electron-electron interactions Weyl semimetals have been shown to have a propensity towards density wave instability [10–13]. The sliding CDW phase mode $\theta(t, x)$ can couple to external electromagnetic fields via an axion term which is proportional to $\theta \mathbf{E} \cdot \mathbf{H}$. Thus, the so-called chiral anomaly can lead to the observed V_T behavior and, consequently, induce a negative longitudinal magnetoresistance. This is consistent with the observed large shift in V_T even for a vanishingly small component of the applied magnetic field $\mathbf{H} || \mathbf{E}$. (ii) The "current jetting effect" where inhomogeneous

current distribution within the voltage probe can lead to the measured voltage decreasing with an increasing magnetic field—an apparent negative longitudinal MR [29]. Systems prone to the current jetting related artifact generally have a high field-induced resistance anisotropy. Bulk single crystals of YIO are unavailable, and among the single crystal iridates available, only Nd₂Ir₂O₇ [30] shows a sizable resistance anisotropy. (iii) Weak localization of the "trivial" quasiparticles in the presence of impurities [31] or quantum interference of CDWs [32]. (iv) The magnetic field can cause a modification of the Fermi surface gap structure and change the ratio of quasiparticle and the CDW condensate density, thereby leading to the lowering of V_T and negative magnetoresistance [33].

In the present case, current jetting can be ruled out with reasonable surety on account of the following reasons. (a) The contact electrodes in our case are not point contacts. They are *e*-beam deposited metal contacts covering the entire cross section of the nanowire. (b) The diameter of the nanowire in our devices is less than 200 nm with a uniform cross section, much less compared to the typical dimensions (few milimeters) of the samples showing current jetting [29]. (c) The diameter to voltage probe length ratio of YIO nanowire is close to 15 and above, large enough to rule out inhomogeneous current distribution playing any part. (d) Finally, the observed negative MR is not "non-saturating," as is the case with the current jetting effect [29]. At a higher magnetic field, we observe a distinct positive contribution to the longitudinal MR.

Weak localization of normal carriers can be ruled out due to the following reasons: (a) There is no negative MR in the presence of a transverse magnetic field; (b) when the magnetic field is applied along the current direction, we do not observe any change of resistance corresponding to the Ohmic regime in the IV characteristics. This completely rules out the role of the normal quasiparticles (not condensed into the DW) in the observed MR behavior. Since there is no negative MR in the presence of a transverse magnetic field, one can rule out negative MR arising out of quantum interference of CDWs as well. Additionally, the applied magnetic field is too low to modify either the band gap or the condensate density of an ordinary CDW [34]. A rough estimate at a low magnetic field of H = 0.01 T, for Fermi velocity $v_F =$ 10^5 m/s and CDW order parameter $\Delta_0 = 300$ K, gives the ratio of the cyclotron frequency ω_c in the CDW to Δ_0 to be $\omega_c/\Delta_0 \sim 0.01$.

In conclusion, the existence of CDW in single-crystalline YIO nanowire is independently confirmed by HRTEM and SAED measurements. Additionally we show that (i) the application of a transverse magnetic field leads to an increase in the depinning threshold voltage in the CDW phase, leading to colossal positive MR which decreases with increasing temperature, and (ii) in the presence of a small longitudinal magnetic field, the CDW sliding threshold voltage decreases significantly, resulting in negative MR. These observations strongly suggest the role of a finite $\mathbf{E} \cdot \mathbf{H}$ dependent chiral anomaly at play in the dynamics of the DW state of the single-crystalline YIO nanowire.

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